



Industrial Internet Innovation Center (Shanghai) Co.,Ltd.

EMC TEST REPORT

PRODUCT	Smart POS System
BRAND	SUNMI
MODEL	T6831
APPLICANT	Shanghai Sunmi Technology Co.,Ltd.
FCC ID	2AH25T6831NA
ISSUE DATE	February 28, 2025
STANDARD(S)	FCC Part 15, Subpart B, ANSI C63.4-2014, ICES-003 Issue 7.

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Reviewed by: Qin Yabin



Approved by: Zhang Min

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1 Summary of Test Report

1.1 Test Standard (s)

No.	Test Standard(s)	Title
1	FCC Part 15, Subpart B	Radio frequency devices
2	ANSI C63.4	Method of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz
3	ICES-003	Information Technology Equipment (Including Digital Apparatus)- Limits and Methods of Measurement
NOTE: According to customer requirements, test and report using the latest version of the standard.		

1.2 Summary of Test Results

No.	Item(s)	FCC Standard(s)	IC Standard(s)	Verdicts for Single Item	Detailed Results
1	Radiated Emission	15.109(a)	3.2.2	Pass	See section 6.1
2	AC Conducted Emission	15.107(a)	3.2.1	Pass	See section 6.2
NOTE: The T6831, manufactured by Shanghai Sunmi Technology Co.,Ltd. is a new product for testing. Industrial Internet Innovation Center (Shanghai) Co., Ltd. only performed test cases which identified with Pass/Fail/Inc result in section 1.3. Industrial Internet Innovation Center (Shanghai) Co., Ltd. has verified that the compliance of the tested device specified in section 4 of this test report is successfully evaluated according to the procedure and test methods as defined in type certification requirement listed in section 1 of this test report.					

2 General Information of The Laboratory

2.1 Testing Laboratory

Lab Name	Industrial Internet Innovation Center (Shanghai) Co.,Ltd.
Address	Building 4, No. 766, Jingang Road, Pudong, Shanghai, China
Telephone	021-68866880
FCC Registration No.	708870
FCC Designation No.	CN1364
IC designation No.	10766A
CAB identifier	CN0067

2.2 Laboratory Environmental Requirements

Temperature	15℃~35℃
Relative Humidity	25%RH~75%RH
Atmospheric Pressure	86kPa~106kPa
Supply Voltage	120V/60Hz

2.3 Project Information

Project Manager	Gao Hongning
Test Date	February 18, 2025 to February 28, 2025

3 General Information of The Customer

3.1 Applicant

Company	Shanghai Sunmi Technology Co.,Ltd.
Address	Room 505, No.388 Song Hu Road, Yang Pu District, Shanghai, China
Telephone	18826519551

3.2 Manufacturer

Company	Shanghai Sunmi Technology Co.,Ltd.
Address	Room 505, No.388 Song Hu Road, Yang Pu District, Shanghai, China
Telephone	18826519551

3.3 Factory

Company	N/A
Address	N/A

4 General Information of The Product

4.1 Product Description for Equipment under Test (EUT)

Product	Smart POS System
Model	T6831
Date of Receipt	February 18, 2025
EUT ID*	S01aa
SN/IMEI	860309070007616'860309070008119
Supported Radio Technology and Bands	WCDMA Band II/IV/V LTE Band 2/4/5/7/12/13/14/17/25/26/30/38/41/66/71 BT 5.0 BR/EDR/BLE WLAN 802.11b,g,n WLAN 802.11a,n,ac GPS/GLONASS/BDS/Galileo NFC
Hardware Version	V1.0(NA)
Software Version	V3.0.1
Power Rating	DC 7.7V from battery, DC 5V from adapter
NOTE1: EUT ID is the internal identification code of the laboratory. NOTE2: Photographs of EUT are shown in ANNEX A of this test report. NOTE3: Samples in the test report are provided by the customer. The test results are only applicable to the samples received by the laboratory.	

4.2 Description for Auxiliary Equipment (AE)

AE ID*	Description	Model	SN/Remark
CA01	Adapter	TPA-141A050200UU01	Shenzhen Tianyin Electronics Co., Ltd. OUTPUT: 5V 2A
CB01	Adapter	TPA-23A050200UU01	Shenzhen Tianyin Electronics Co., Ltd. OUTPUT: 5V 2A
CC01	Adapter	UC13US	Jiangsu Chenyang Electron Co., Ltd. OUTPUT: 5V 2A
UA01	AC Cable	N/A	N/A
BA01	Battery	HPPA	Guangdong Highpower New Energy Technology Co., Ltd. 2550mAH 7.7V
AE1	Notebook PC	Thinkpad	N/A
AE2	Desktop PC	OptiPlex 790 DT	X8RP1 A01 APCC
AE3	LAN Cable	N/A	N/A

AE4	VGA Cable	N/A	N/A
AE5	RS232 Cable	N/A	N/A
AE6	Keyboard	KB212-B	CN-0Y88XT-65890-12I-005Q-A00
AE7	Mouse	MS111-P	CN-011D3V-71581-19J-1A64
AE8	Monitor	Dell E1709Wc	N/A
AE9	Micro SD card	Kingston SDC4/4GB 77	N/A
AE10	Earphone	N/A	N/A
NOTE: *AE ID is the internal identification code of the laboratory.			

5 Test Configuration Information

5.1 Laboratory Environmental Conditions

5.1.1 Permanent Facilities

Semi-anechoic chamber SAC3-1 (9 m*8m*6.2m) & SAC3-2 (9.8m*6.7m*6.7m)	
Shielding effectiveness	0.014MHz ~1MHz, >60dB; 1MHz~1000MHz, >90dB.
Electrical insulation	> 2MΩ
Ground system resistance	< 4Ω
Normalised site attenuation (NSA)	< ± 4 dB, 3m distance, from 30 to 1000 MHz
Site voltage standing-wave ratio (SVSWR)	Between 0 and 6 dB, from 1GHz to 18GHz
Uniformity of field strength	Between 0 and 6 dB, from 80 to 6000 MHz

Shielded room	
Shielding effectiveness	0.014MHz~1MHz, >60dB; 1MHz~1000MHz, >90dB.
Electrical insulation	> 2 MΩ
Ground system resistance	< 4Ω

5.2 Decision of final test mode

The EUT was tested in conjunction with the accessories in Section 4.2. We tested all of the following test modes and selected the worst mode from the test results and recorded them in the report.

The test configuration modes are as the following:

Test Item	Test setup and operating modes
Radiated emission	30MHz-18GHz frequency range: Mode 1: WCDMA BAND II receiver mode+ Front Camera+ CA01+ UA01+ BA01 Mode 2: WCDMA BAND II receiver mode+ Back Camera+ CA01+ UA01+ BA01 Mode 3: LTE Band 2 receiver mode+ Back Camera+ CB01+ UA01+ BA01 Mode 4: LTE Band 41 receiver mode+ Back Camera+ CC01+ UA01+ BA01 Mode 5: GNSS mode+ CC01+ UA01+ BA01 Mode 7: Print mode+ CC01+ UA01+ BA01 Mode 9: Full system+ Data Link mode+ UA01+ BA01+ AE
AC Conducted emission	Mode 1: WCDMA BAND II receiver mode+ Front Camera+ CA01+ UA01+ BA01 Mode 2: WCDMA BAND II receiver mode+ Back Camera+ CA01+ UA01+ BA01 Mode 3: LTE Band 2 receiver mode+ Back Camera+ CB01+ UA01+ BA01 Mode 4: LTE Band 41 receiver mode+ Back Camera+ CC01+ UA01+ BA01 Mode 6: GNSS mode+ CB01+ UA01+ BA01 Mode 8: Print mode+ CB01+ UA01+ BA01 Mode 9: Full system+ Data Link mode+ UA01+ BA01+ AE
Note: 1. All test modes are performed, only the worst cases test data are recorded in this report. 2. After laboratory verification, WCDMA BAND II/LTE Band 2/41 is the worst mode among all receiving modes of 3G/4G and is recorded in the report. 3. The worst case of radiated emission for 30MHz-1GHz is Mode 7 and for 1GHz -18GHz is Mode 9. 4. The worst case for conducted emission is mode 9.	

5.3 EUT System Operation

1. Connect the EUT with AE.
2. Setup the EUT according to the standard.
3. Start testing and monitoring the function.
4. Data Link mode means data application transferred mode between EUT, SD Card and PC.
5. GNSS mode: EUT and GNSS simulator (SMBV100A) connection is established.

5.4 EUT Connection Diagram of Test System

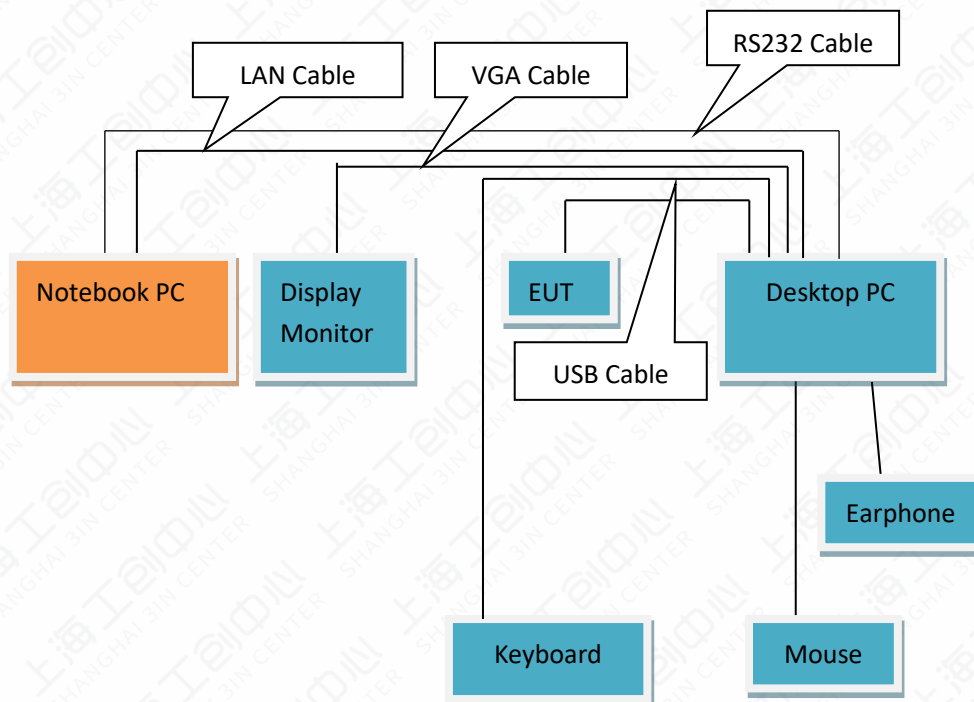


Figure 5.4-1 Mode 9

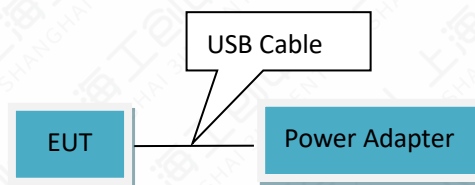


Figure 5.4-2 Mode 1-8

5.5 Test Equipment Utilized

No.	Name	Model	S/N	SW Version	HW Version	Manufacturer	Cal. Date	Cal. Interval
1	Test Receiver	ESCI	101235	V5.1-24-3	00	R&S	2025-01-05	1 year
2	Test Receiver	ESR7	102399	1.4	00	R&S	2024-06-07	1 year
3	Test Receiver	FSW43	101943	1.12	00	R&S	2024-08-21	1 year
4	Trilog Antenna	VULB9162	00426	N/A	N/A	Schwarzbeck	2024-08-02	1 year
5	Double Ridged Guide Antenna	ETS-3117	00135885	N/A	N/A	ETS	2025-01-11	1 year
6	2-Line V-Network	ENV216	101380	N/A	N/A	R&S	2024-12-23	1 year
7	EMI Test Software	EMC32 V10.35.02	N/A	N/A	N/A	R&S	N/A	N/A
8	EMI Test Software	EMC32 V10.60.20	N/A	N/A	N/A	R&S	N/A	N/A
9	Universal Radio Communication Tester	CMW500	104178	V3.7.20	1206.06 00.00	R&S	2024-12-13	1 year
10	Vector signal generator	SMBV100 A	257904	N/A	N/A	R&S	2024-12-13	1 year
11	Preamplifier	SCU08F1	8320024	N/A	N/A	R&S	2024-10-09	1 year
12	Preamplifier	SCU18	10155	N/A	N/A	R&S	2024-10-09	1 year

Test Cable: According to the quality management system of our laboratory, the measurement cables used for testing are calibrated every two years. The next calibration is scheduled for 2025-06-20.

5.6 Measurement Uncertainty

Item (s)	Uncertainty
Radiated Emission 30MHz-1000MHz	4.86 dB
Radiated Emission 1000MHz-18000MHz	5.58 dB
Conducted Emission	3.30 dB

Note: This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k=2$.

6 Test Results

6.1 Radiated Emission

6.1.1 Method of Measurement

- a. For 30MHz -1000MHz, the EUT was placed on the top of a rotating 0.8m table above the ground at a semi-anechoic chamber. The distance between the EUT and the received antenna was 3 meters. The table was rotated 360 degree and the received antenna mounted on a variable-height antenna tower was varied from 1m to 4m to find the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna were set during the measurement.
- b. For 1000MHz -18000MHz, the EUT was placed on the top of a 0.8m table above the ground at a 3m fully anechoic chamber. The maximal emission value was acquired by adjusting the antenna height, The table was rotated 360 degrees to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna were set during the measurement

6.1.2 EUT Connection Diagram of Test System

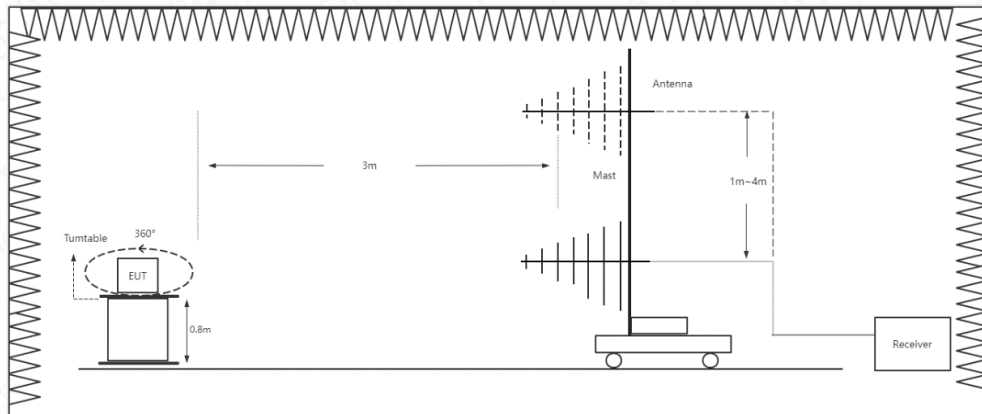


Figure 6.1.2-1 RE 30MHz-1GHz Connection Diagram

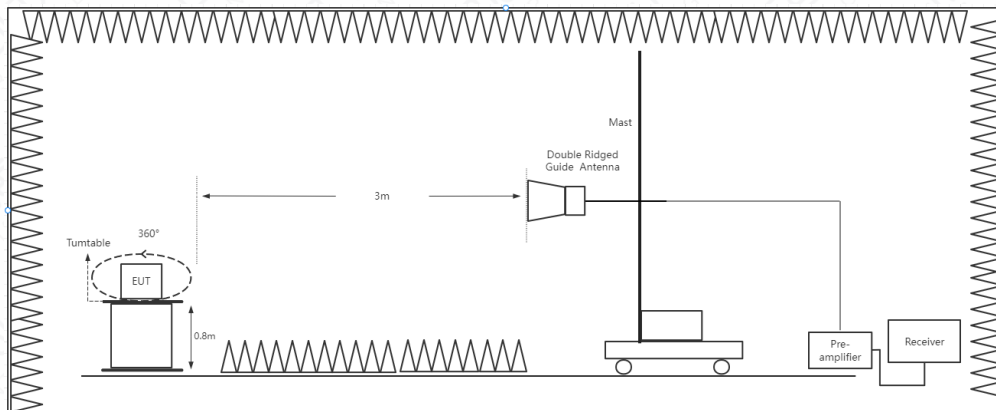


Figure 6.1.2-2 RE Above 1GHz Connection Diagram

6.1.3 Test Condition

Frequency Range (MHz)	RBW/VBW	Sweep Time (s)
30-1000	120kHz/300kHz	AUTO
1000-18000	1MHz/3MHz	AUTO

6.1.4 Limit/Criterion

Frequency Range (MHz)	Quasi-Peak (dBμV/m)	Peak (dBμV/m)	Average (dBμV/m)
30-88	40	N/A	N/A
88-216	43.5	N/A	N/A
216-960	46	N/A	N/A
Above 960	54	N/A	N/A
Above 1000	N/A	74	54

6.1.5 Test environmental conditions

Temperature	19.4℃
Relative Humidity	42.6%RH
Atmospheric Pressure	102.0 kPa

6.1.6 Test Results

Mode	Frequency (MHz)	Test Results	Verdicts
Mode 7: Print mode+ CC01+ UA01+ BA01	30-1000	See Annex A.1-1	Pass
Mode 9: Full system+ Data Link mode+ UA01+ BA01+ AE	1000-18000	See Annex A.1-2 & A.1-3	Pass
NOTE Abbreviations used in this clause: Pass—P; Fail—F; Not applicable—N/A			

6.2 Conducted Emission

6.2.1 Method of Measurement

The EUT was placed on a 0.8m height table with EUT being connected to the power mains through a line impedance stabilization network (LISN). Both lines of the power mains connected to the EUT were checked for maximum conducted interference. The frequency range from 150 kHz to 30 MHz was searched.

6.2.2 EUT Connection Diagram of Test System

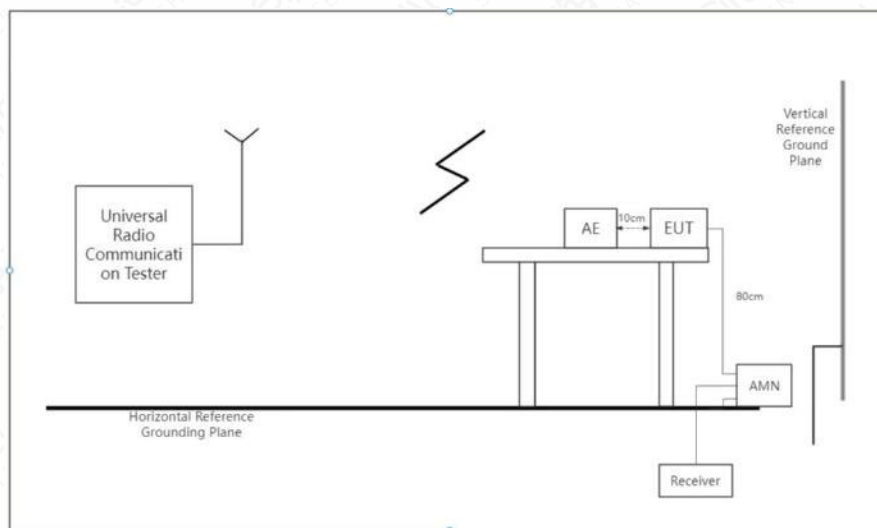


Figure 6.2.2-1 CE Connection Diagram

6.2.3 Test Condition

Test Condition in Charging Mode

Voltage (V)	Frequency (Hz)	RBW	Sweep Time (s)
120	60	9 kHz	AUTO

6.2.4 Limit

Frequency Range (MHz)	Conducted Limit (dBμV)	
	Quasi-peak	Average
0.15-0.5	66 to 56*	56 to 46*
0.5-5	56	46
5-30	60	50
*Decreases with the logarithm of the frequency		

6.2.5 Testing environmental conditions

Temperature	20.3℃
Relative Humidity	35.7%RH
Atmospheric Pressure	100.6kPa

6.2.6 Test Results

Mode	Frequency (MHz)	Test Results	Verdicts
Mode 9: Full system+ Data Link mode+ UA01+ BA01+ AE	0.15-30	See Annex A.2-1	Pass
NOTE Abbreviations used in this clause: Pass—P; Fail—F; Not applicable—N/A			

Annex A: Measurement Data

A.1 Radiated Emission

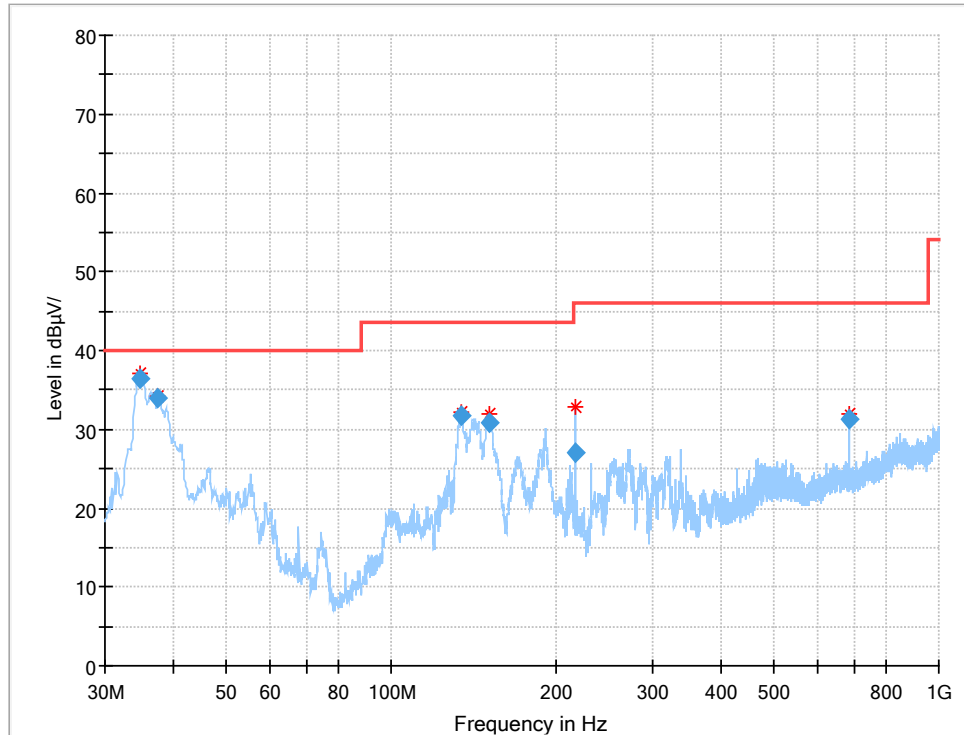


Figure A.1-1 Mode 7 (30M-1GHz)

Frequency (MHz)	QuasiPeak (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
34.853080	36.46	40.00	3.54	100.0	V	251.0	-14.9
37.441960	33.87	40.00	6.13	100.0	V	194.0	-14.1
134.532520	31.69	43.50	11.81	100.0	V	355.0	-16.1
150.715400	30.77	43.50	12.73	100.0	V	0.0	-16.2
217.497880	27.11	46.00	18.89	100.0	H	260.0	-12.5
684.008680	31.36	46.00	14.64	100.0	H	38.0	-1.3

Note:

1.Horizontal and vertical polarity is all have been tested, the result of them is synthesized in the above data diagram.

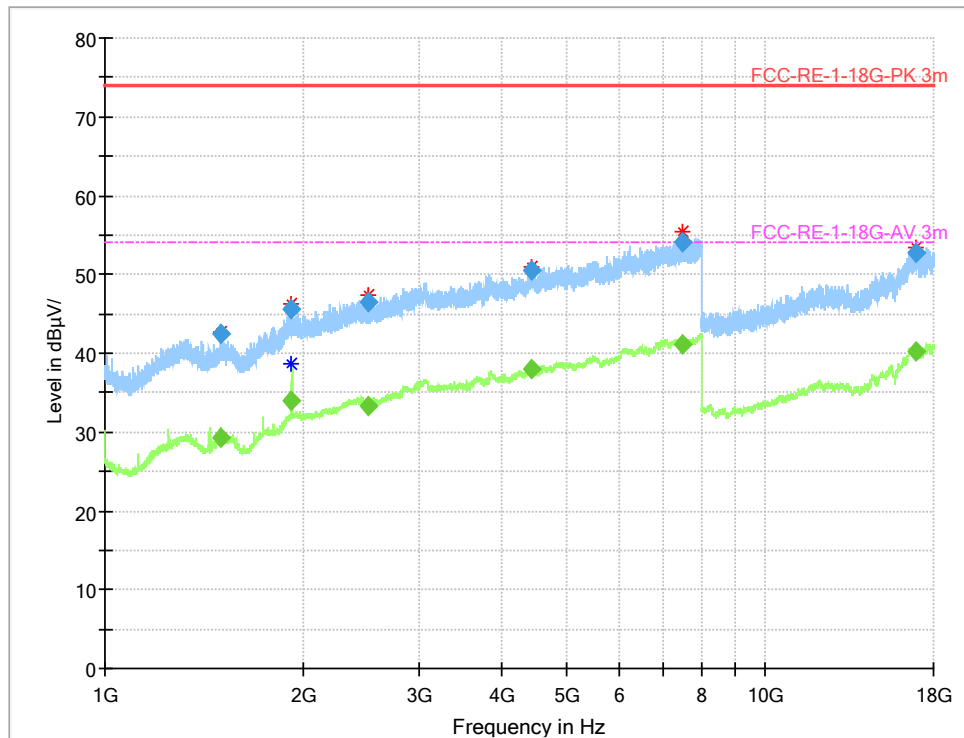


Figure A.1-2 Mode 9 (1GHz-18GHz)-H

Frequency (MHz)	MaxPeak (dBμV/m)	Average (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
1497.013750	42.56	---	74.00	31.44	185.0	H	140.0	2.7
1497.013750	---	29.26	54.00	24.74	185.0	H	140.0	2.7
1919.465000	---	34.00	54.00	20.00	188.0	H	280.0	6.6
1919.465000	45.61	---	74.00	28.39	188.0	H	280.0	6.6
2498.685000	---	33.20	54.00	20.80	115.0	H	0.0	8.4
2498.685000	46.41	---	74.00	27.59	115.0	H	0.0	8.4
4426.617500	---	37.90	54.00	16.10	215.0	H	19.0	14.4
4426.617500	50.48	---	74.00	23.52	215.0	H	19.0	14.4
7489.625000	---	41.18	54.00	12.82	215.0	H	0.0	20.6
7489.625000	54.03	---	74.00	19.97	215.0	H	0.0	20.6
16888.175000	52.63	---	74.00	21.37	188.0	H	355.0	21.8
16888.175000	---	40.17	54.00	13.83	188.0	H	355.0	21.8

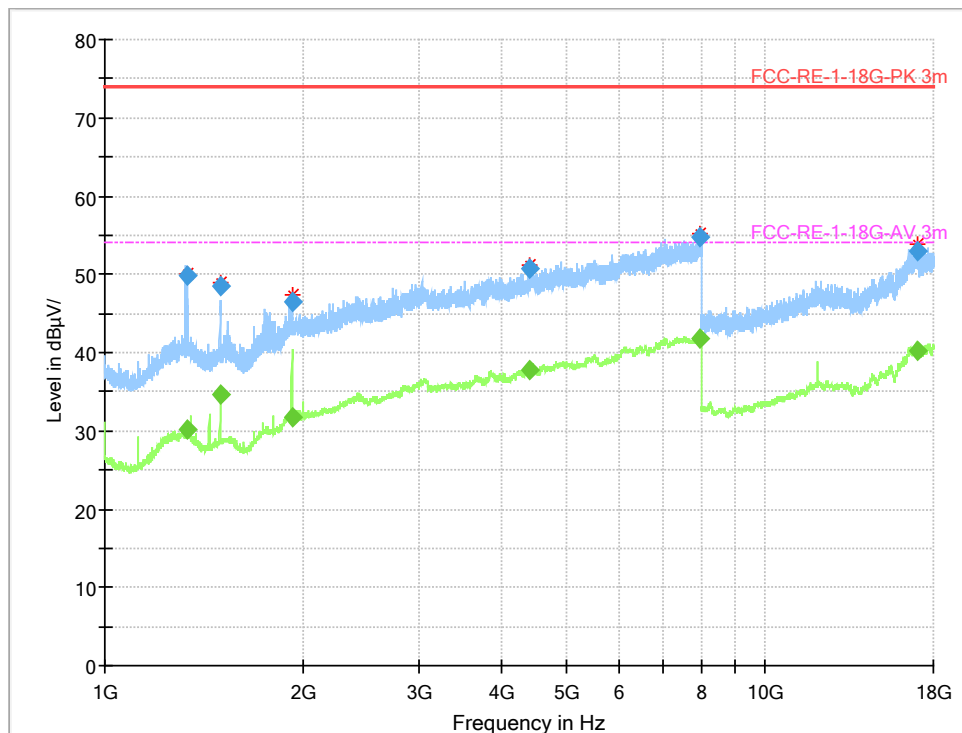


Figure A.1-3 Mode 9 (1GHz-18GHz)-V

Frequency (MHz)	MaxPeak (dBμV/m)	Average (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
1330.163750	49.74	---	74.00	24.26	100.0	V	248.0	3.1
1330.163750	---	30.12	54.00	23.88	100.0	V	248.0	3.1
1496.720000	48.48	---	74.00	25.52	100.0	V	190.0	2.7
1496.720000	---	34.54	54.00	19.46	100.0	V	190.0	2.7
1922.103750	---	31.80	54.00	22.20	115.0	V	248.0	6.7
1922.103750	46.43	---	74.00	27.57	115.0	V	248.0	6.7
4412.963750	---	37.75	54.00	16.25	115.0	V	286.0	14.2
4412.963750	50.67	---	74.00	23.33	115.0	V	286.0	14.2
7959.388750	---	41.78	54.00	12.22	115.0	V	286.0	21.2
7959.388750	54.69	---	74.00	19.31	115.0	V	286.0	21.2
17043.613750	---	40.29	54.00	13.71	185.0	V	344.0	21.8
17043.613750	52.87	---	74.00	21.13	185.0	V	344.0	21.8

A.2 Conducted Emission

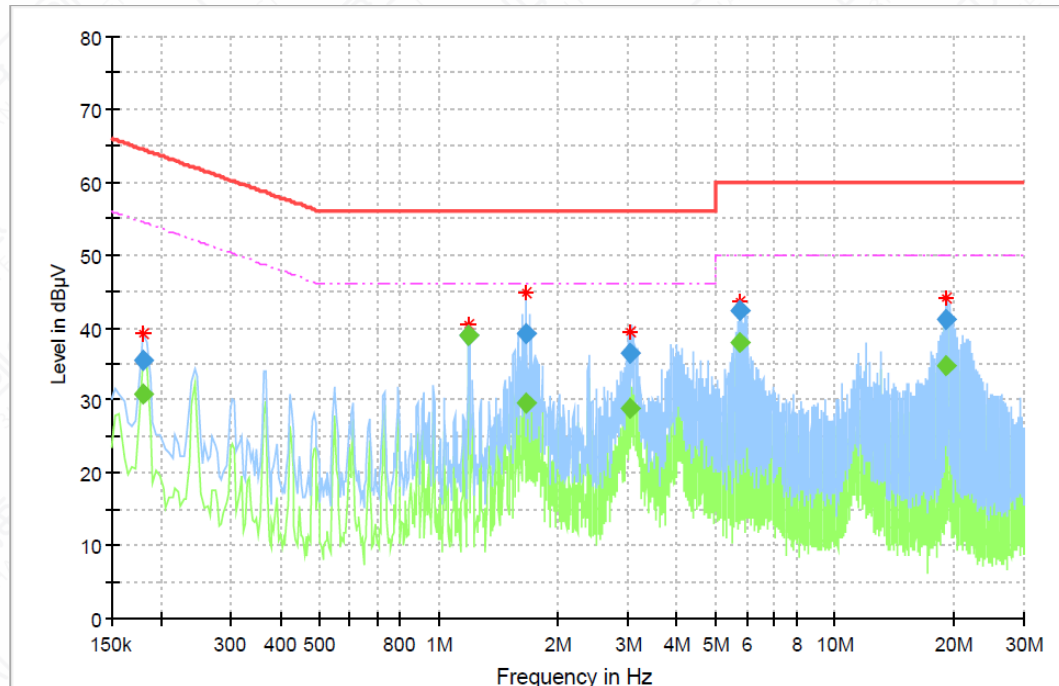


Figure A.2-1 Mode 9 (150kHz-30MHz)

Frequency (MHz)	QuasiPeak (dBμV)	Average (dBμV)	Limit (dBμV)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Line	Filter	Corr. (dB)
0.179850	---	30.78	54.49	23.72	15000.0	9.000	N	ON	10.0
0.179850	35.51	---	64.49	28.98	15000.0	9.000	N	ON	10.0
1.194750	---	38.79	46.00	7.21	15000.0	9.000	N	ON	9.8
1.194750	38.95	---	56.00	17.05	15000.0	9.000	N	ON	9.8
1.668619	---	29.57	46.00	16.43	15000.0	9.000	N	ON	9.9
1.668619	39.19	---	56.00	16.81	15000.0	9.000	N	ON	9.9
3.052913	---	28.89	46.00	17.11	15000.0	9.000	N	ON	9.8
3.052913	36.42	---	56.00	19.58	15000.0	9.000	N	ON	9.8
5.735681	---	37.92	50.00	12.08	15000.0	9.000	N	ON	9.7
5.735681	42.21	---	60.00	17.80	15000.0	9.000	N	ON	9.7
19.153256	---	34.62	50.00	15.38	15000.0	9.000	N	ON	9.4
19.153256	41.20	---	60.00	18.80	15000.0	9.000	N	ON	9.4

Note: L1 and N line is all have been tested, the result of them is synthesized in the above data diagram.

Annex B: Revised History

Version	Revised Content
V0	Initial

Annex C: Accreditation Certificate**Accredited Laboratory**

A2LA has accredited

**INDUSTRIAL INTERNET INNOVATION CENTER
(SHANGHAI) CO., LTD.**

Shanghai, People's Republic of China

for technical competence in the field of

Electrical Testing

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 General requirements for the competence of testing and calibration laboratories. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).

Presented this 20th day of September 2023.

Mr. Trace McInturff, Vice President, Accreditation Services
For the Accreditation Council
Certificate Number 3682.01
Valid to April 30, 2025
Revised February 24, 2025

For the tests to which this accreditation applies, please refer to the laboratory's Electrical Scope of Accreditation.